## INTEGRATED CIRCUITS

## DATA SHEET

# **74LV02**Quad 2-input NOR gate

Product data Supersedes data of 1998 Apr 20





**Philips Semiconductors Product data** 

## **Quad 2-input NOR gate**

74LV02

#### **FEATURES**

• Wide operating voltage: 1.0 to 5.5 V

Optimized for low voltage applications: 1.0 to 5.5 V

Accepts TTL input levels between V<sub>CC</sub> = 2.7 V and V<sub>CC</sub> = 3.6 V

 Typical V<sub>OLP</sub> (output ground bounce) < 0.8 V at V<sub>CC</sub> = 3.3 V,  $T_{amb} = 25 \, ^{\circ}C$ 

 Typical V<sub>OHV</sub> (output V<sub>OH</sub> undershoot) > 2 V at V<sub>CC</sub> = 3.3 V, T<sub>amb</sub> = 25 °C

Output capability: standard

I<sub>CC</sub> category: SSI

#### DESCRIPTION

The 74LV02 is a low-voltage Si-gate CMOS device that is pin and function compatible with 74HC/HCT02.

The 74LV02 provides the 2-input NOR function.

## **QUICK REFERENCE DATA**

GND = 0 V;  $T_{amb} = 25^{\circ}C$ ;  $t_r = t_f \le 2.5 \text{ ns}$ 

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t <sub>PHL</sub> /t <sub>PLH</sub>	Propagation delay nA, nB to nY	$C_L = 15 \text{ pF};$ $V_{CC} = 3.3 \text{ V}$	6	ns
C <sub>I</sub>	Input capacitance		3.5	pF
C <sub>PD</sub>	Power dissipation capacitance per gate	See Notes 1 and 2	22	pF

#### NOTES:

 $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ )

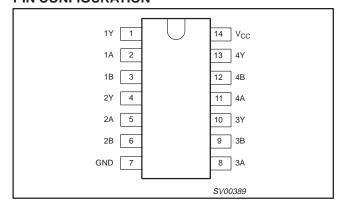
 $P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \Sigma (C_L \times V_{CC}^2 \times f_o)$  where: N = number of outputs switching;

Fi = input frequency in MHz; C<sub>L</sub> = output load capacitance in pF;
 f<sub>0</sub> = output frequency in MHz; V<sub>CC</sub> = supply voltage in V;
 Σ (C<sub>L</sub> × V<sub>CC</sub><sup>2</sup> × f<sub>0</sub>) = sum of the outputs.
 The condition is V<sub>I</sub> = GND to V<sub>CC</sub>.

#### ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	ORDER CODE	PKG. DWG. #
14-Pin Plastic SO	–40 °C to +125 °C	74LV02D	SOT108-1

## PIN CONFIGURATION



## PIN DESCRIPTION

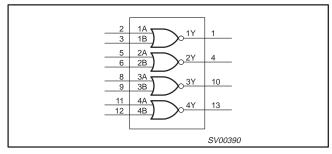
PIN NUMBER	SYMBOL	FUNCTION
1, 4, 10, 13	1Y – 4Y	Data outputs
2, 5, 8, 11	1A – 4A	Data inputs
3, 6, 9, 12	1B – 4B	Data inputs
7	GND	Ground (0 V)
14	V <sub>CC</sub>	Positive supply voltage

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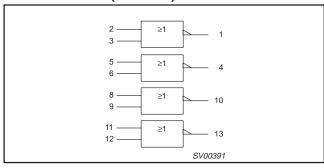
## Quad 2-input NOR gate

74LV02

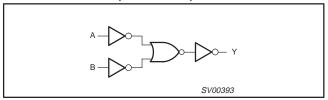
## LOGIC SYMBOL



## LOGIC SYMBOL (IEEE/IEC)



## **LOGIC DIAGRAM (ONE GATE)**



#### **FUNCTION TABLE**

INP	OUTPUTS	
nA	nB	nY
L	L	Н
L	Н	L
Н	L	L
Н	Н	L

## NOTES:

H = HIGH voltage level

L = LOW voltage level

## **RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP.	MAX	UNIT
V <sub>CC</sub>	DC supply voltage	See Note 1	1.0	3.3	5.5	V
VI	Input voltage		0	_	V <sub>CC</sub>	V
Vo	Output voltage		0	_	V <sub>CC</sub>	V
T <sub>amb</sub>	Operating ambient temperature range in free air	See DC and AC characteristics	-40 -40		+85 +125	°C
t <sub>r</sub> , t <sub>f</sub>	Input rise and fall times	$V_{CC} = 1.0 \text{ V to } 2.0 \text{ V}$ $V_{CC} = 2.0 \text{ V to } 2.7 \text{ V}$ $V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$ $V_{CC} = 3.6 \text{ V to } 5.5 \text{ V}$	- - -	- - -	500 200 100 50	ns/V

#### NOTE

The LV is guaranteed to function down to V<sub>CC</sub> = 1.0 V (input levels GND or V<sub>CC</sub>); DC characteristics are guaranteed from V<sub>CC</sub> = 1.2 V to V<sub>CC</sub> = 5.5 V.

## **ABSOLUTE MAXIMUM RATINGS<sup>1, 2</sup>**

In accordance with the Absolute Maximum Rating System (IEC 134). Voltages are referenced to GND (ground = 0 V).

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V <sub>CC</sub>	DC supply voltage		-0.5 to +7.0	V
±I <sub>IK</sub>	DC input diode current	$V_{I} < -0.5 \text{ V or } V_{I} > V_{CC} + 0.5 \text{ V}$	20	mA
±l <sub>OK</sub>	DC output diode current	$V_{O} < -0.5 \text{ V or } V_{O} > V_{CC} + 0.5 \text{ V}$	50	mA
±ΙΟ	DC output source or sink current (standard outputs)	$-0.5 \text{ V} < \text{V}_{\text{O}} < \text{V}_{\text{CC}} + 0.5 \text{ V}$	25	mA
±I <sub>GND</sub> , ±I <sub>CC</sub>	DC V <sub>CC</sub> or GND current	for types with standard outputs	50	mA
T <sub>stg</sub>	Storage temperature range		-65 to +150	°C
P <sub>TOT</sub>	Power dissipation per package  – plastic mini-pack (SO)	for temperature range: -40 °C to +125 °C above +70 °C derate linearly with 8 mW/K	500	mW

## NOTES:

- 1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- 2. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

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## DC ELECTRICAL CHARACTERISTICS

Over recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

					LIMITS			
SYMBOL	PARAMETER	TEST CONDITIONS	-40	°C to +8	5 °C	–40 °C to	0.3 0.6 0.8 0.3*V <sub>CC</sub> 0.2 0.2 0.2 0.2 0.2 0.50 0.65	וואט
			MIN	TYP.1	MAX	MIN	MAX	V V V V μA
		V <sub>CC</sub> = 1.2 V	0.9			0.9		
$V_{IH}$	HIGH level Input	V <sub>CC</sub> = 2.0 V	1.4			1.4		] ,,
VIН	voltage	V <sub>CC</sub> = 2.7 V to 3.6 V	2.0			2.0		ľ
		V <sub>CC</sub> = 4.5 V to 5.5 V	0.7*V <sub>CC</sub>			0.7*V <sub>CC</sub>		
		V <sub>CC</sub> = 1.2 V			0.3		0.3	
\/	LOW level Input	V <sub>CC</sub> = 2.0 V			0.6		0.6	] ,
$V_{IL}$	voltage	V <sub>CC</sub> = 2.7 V to 3.6 V			0.8		0.8	]
	V <sub>CC</sub> = 4.5 V to 5.5 V			0.3*V <sub>CC</sub>		0.3*V <sub>CC</sub>	1	
		$V_{CC} = 1.2 \text{ V}; V_I = V_{IH} \text{ or } V_{IL}; -I_O = 100 \mu\text{A}$		1.2				
		$V_{CC} = 2.0 \text{ V}; V_I = V_{IH} \text{ or } V_{IL}; -I_O = 100 \mu\text{A}$	1.8	2.0		1.8		
	HIGH level output voltage; all outputs	$V_{CC}$ = 2.7 V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $-I_O$ = 100 $\mu$ A	2.5	2.7		2.5		V
	Voltago, all outputo	$V_{CC} = 3.0 \text{ V}; V_I = V_{IH} \text{ or } V_{IL}; -I_O = 100 \mu\text{A}$	2.8	3.0		2.8		
		$V_{CC} = 4.5 \text{ V}; V_I = V_{IH} \text{ or } V_{IL;} -I_O = 100 \mu\text{A}$	4.3	4.5		4.3		1
V	HIGH level output voltage; STANDARD	$V_{CC} = 3.0 \text{ V}; V_I = V_{IH} \text{ or } V_{IL;} -I_O = 6 \text{ mA}$	2.40	2.82		2.20		V
V <sub>OH</sub>	outputs	$V_{CC} = 4.5 \text{ V}$ ; $V_I = V_{IH} \text{ or } V_{IL}$ ; $-I_O = 12 \text{ mA}$	3.60	4.20		3.50		\ \ \
		$V_{CC}$ = 1.2 V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $I_O$ = 100 $\mu A$		0				
		$V_{CC}$ = 2.0 V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $I_O$ = 100 $\mu A$		0	0.2		0.2	]
$V_{OL}$	LOW level output voltage; all outputs	$V_{CC}$ = 2.7 V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $I_O$ = 100 $\mu A$		0	0.2		0.2	\ \
		$V_{CC}$ = 3.0 V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $I_O$ = 100 $\mu A$		0	0.2		0.2	1
		$V_{CC}$ = 4.5 V; $V_I$ = $V_{IH}$ or $V_{IL;}$ $I_O$ = 100 $\mu A$		0	0.2		0.2	
W	LOW level output voltage; STANDARD	$V_{CC} = 3.0 \text{ V}; V_I = V_{IH} \text{ or } V_{IL}; I_O = 6 \text{ mA}$		0.25	0.40		0.50	\ \ \
$V_{OL}$	outputs	$V_{CC} = 4.5 \text{ V}; V_I = V_{IH} \text{ or } V_{IL}, I_O = 12 \text{ mA}$		0.35	0.55		0.65	ľ
l <sub>l</sub>	Input leakage current	$V_{CC} = 5.5 \text{ V}; V_I = V_{CC} \text{ or GND}$			1.0		1.0	μΑ
I <sub>CC</sub>	Quiescent supply current; SSI	$V_{CC} = 5.5 \text{ V}; V_{I} = V_{CC} \text{ or GND}; I_{O} = 0$			20.0		40	μА
Δl <sub>CC</sub>	Additional quiescent supply current	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}; V_{I} = V_{CC} -0.6 \text{ V}$			500		850	μА

## NOTE:

<sup>1.</sup> All typical values are measured at  $T_{amb}$  = 25  $^{\circ}\text{C}.$ 

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#### **AC CHARACTERISTICS**

GND = 0 V;  $t_r$  =  $t_f$   $\leq$  2.5 ns;  $C_L$  = 50 pF;  $R_L$  = 1  $k\Omega$ 

			CONDITION	LIMITS					
SYMBOL	PARAMETER	WAVEFORM	CONDITION	-40	-40 °C to +85 °C				UNIT
			V <sub>CC</sub> (V)	MIN	TYP. <sup>1</sup>	MAX	MIN	MAX	
			1.2		40				
			2.0		14	21		26	
t <sub>PHL</sub> /t <sub>PLH</sub>	Propagation delay nA, nB to nY	Figures 1, 2	2.7		10	15		19	ns
			3.0 to 3.6		7.5 <sup>2</sup>	12		15	
			4.5 to 5.5		6.0 <sup>3</sup>	10		13	

### NOTES:

- Unless otherwise stated, all typical values are measured at T<sub>amb</sub> = 25 °C
   Typical values are measured at V<sub>CC</sub> = 3.3 V.
   Typical values are measured at V<sub>CC</sub> = 5.0 V.

## **AC WAVEFORMS**

 $V_M = 1.5 \text{ V at } V_{CC} \ge 2.7 \text{ V and } \le 3.6 \text{ V};$ 

 $V_M = 0.5 \times V_{CC}$  at  $V_{CC} < 2.7$  V and  $\ge 4.5$  V;

 $V_{\mbox{\scriptsize OL}}$  and  $V_{\mbox{\scriptsize OH}}$  are the typical output voltage drop that occur with the output load.

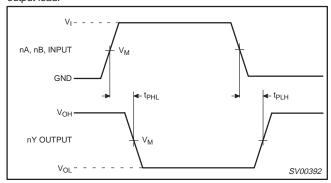


Figure 1. Input (nA, nB) to output (nY) propagation delays.

## **TEST CIRCUIT**

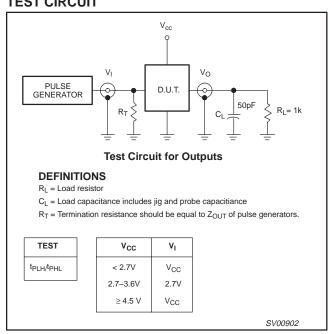


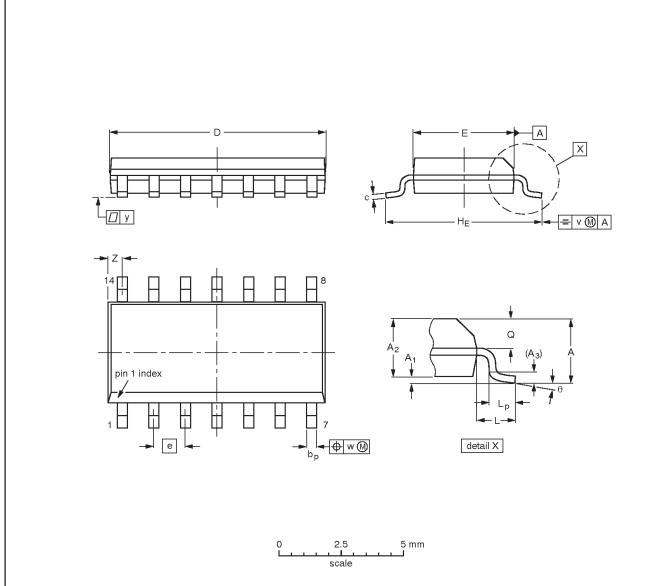
Figure 2. Load circuitry for switching times.

## Quad 2-input NOR gate

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## SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1



## DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	HE	L	Lp	Q	>	w	у	Z <sup>(1)</sup>	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	8.75 8.55	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01	0.019 0.014	0.0100 0.0075	0.35 0.34	0.16 0.15	0.050	0.244 0.228	0.041	0.039 0.016		0.01	0.01	0.004	0.028 0.012	0°

#### Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT108-1	076E06	MS-012			<del>-97-05-22-</del> 99-12-27

2003 Mar 03 6

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#### REVISION HISTORY

Rev	Date	Description
_3	20030303	Product data (9397 750 11189). ECN 853-1899 29489 of 07 February 2003. Supersedes data of 1998 Apr 20 (9397 750 04402).
		Modifications:
		Delete DIL, SSOP and TSSOP package ordering and package outlines (discontinued options).
		Correct power dissipation formula.
_2	19980420	Product data (9397 750 04402). ECN 853-1899 19257 of 20 April 1998. Supersedes data of 1997 Feb 03.

#### **Data sheet status**

Level	Data sheet status <sup>[1]</sup>	Product status <sup>[2]</sup> [3]	Definitions
I	Objective data	Development	This data sheet contains data from the objective specification for product development.  Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
III	Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN).

<sup>[1]</sup> Please consult the most recently issued data sheet before initiating or completing a design.

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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Document order number: 9397 750 11189

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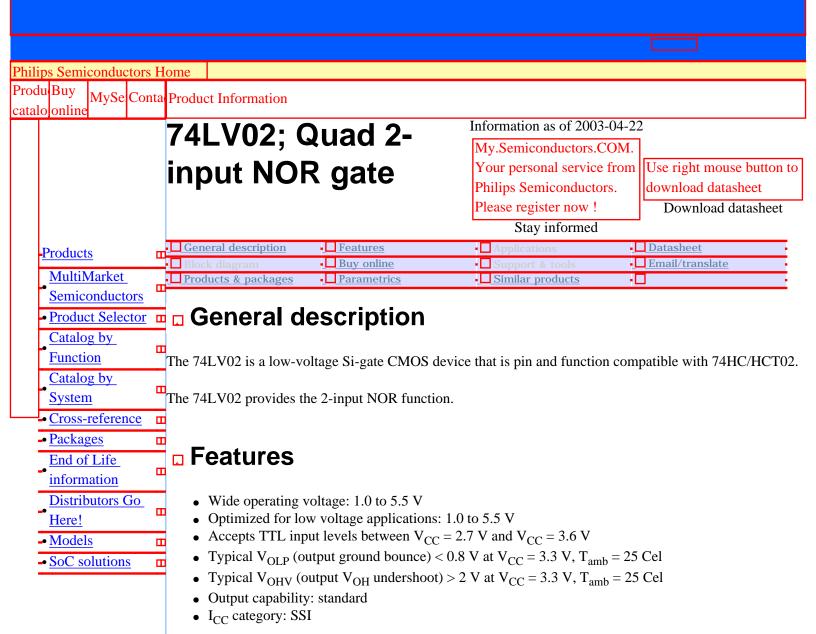
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<sup>[2]</sup> The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.

<sup>[3]</sup> For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.



## Datasheet

Type number	<b>Title</b>	<b>Publication release</b>	<b>Datasheet status</b>	Page	File	Datasheet
		date		count	size (kB)	
74LV02	Quad 2- input NOR gate	3/3/2003	Product specification	7	69	<u>Download</u>

## □ Parametrics

Type number	Package	Description	Propagation Delay(ns)	Voltage	of		Logic Switching Levels	Output Drive Capability
74LV02D	SOT108- 1 (SO14)	Quad 2- Input NOR Gate	15	Low	14	Low Power or Battery Applications	TTL	Low

## Products, packages, availability and ordering

Type number	North American type number	Ordering code (12NC)	Marking/Packing  IC packing info	<b>Package</b>	<u>Device status</u>	Buy online
74LV02D	74LV02D	9350 631 10112	Standard Marking * Tube	SOT108-1 (SO14)	Full production	order this -
	74LV02D- T	9350 631 10118	Standard Marking * Reel Pack, SMD, 13"	SOT108-1 (SO14)	Full production	order this -

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<u>74LV02</u> links to the similar products page containing an overview of products that are similar in function or related to the type number(s) as listed on this page. The similar products page includes products from the same catalog tree(s), relevant selection guides and products from the same functional category.

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